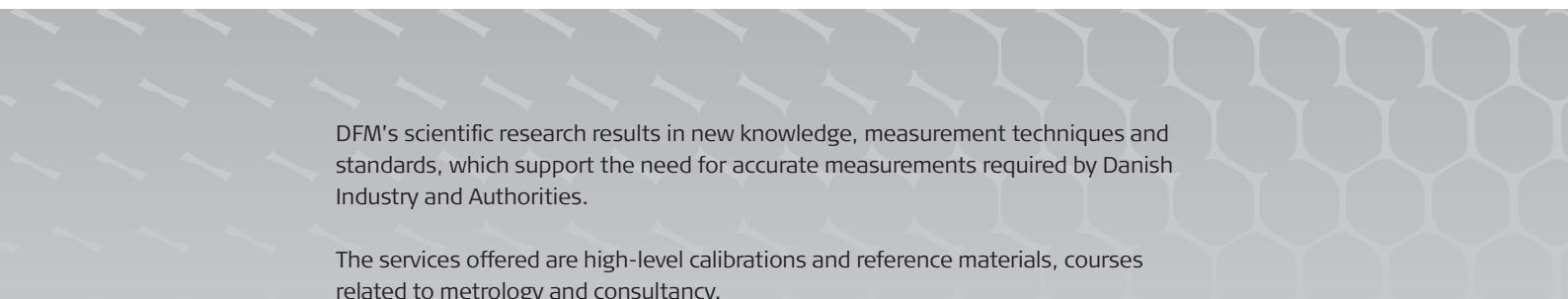


## ANNUAL REPORT AND STATEMENT OF INCOME FOR 2009

DANISH FUNDAMENTAL METROLOGY



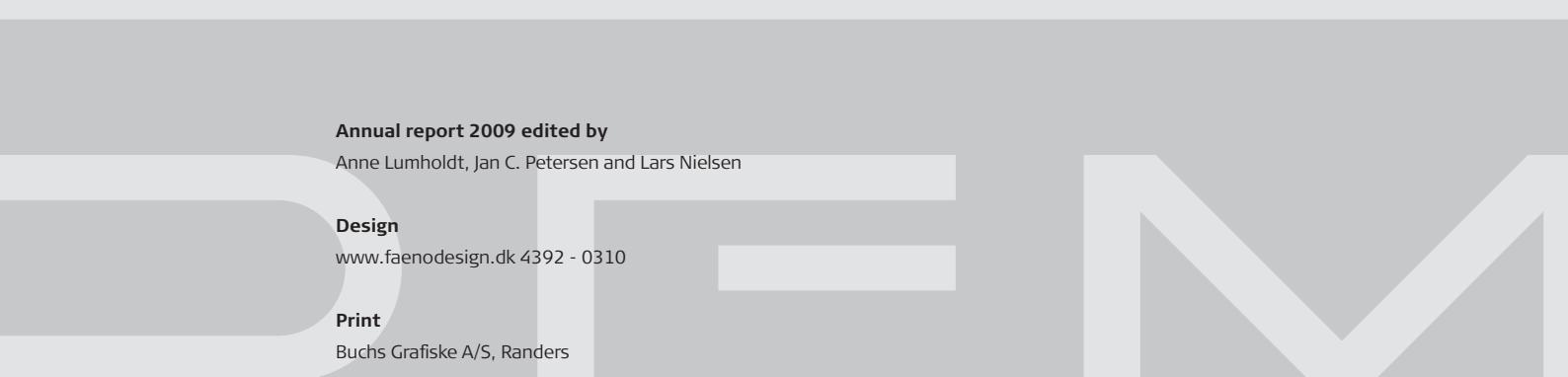


DFM's scientific research results in new knowledge, measurement techniques and standards, which support the need for accurate measurements required by Danish Industry and Authorities.

The services offered are high-level calibrations and reference materials, courses related to metrology and consultancy.

DFM has a special role in developing measurement capabilities, needed by small and medium sized high-tech companies in order for them to evolve and prosper.

DFM works to ensure global confidence in Danish metrological services, which is critical for competing in the global market place.



**Annual report 2009 edited by**  
Anne Lumholdt, Jan C. Petersen and Lars Nielsen

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# LEDESENS BERETNING 2009

Metrologi har været et fokusområde for Rådet for Teknologi og Innovation i perioden 2007 - 2009. Dette har muliggjort en række nye initiativer, herunder deltagelse i et fælleseuropæisk metrologiforskningsprogram, i klimarelaterede metrologiprojekter og i en styrkelse af dansk metrologis organisation og internationale engagement. Disse initiativer er i det forløbne år afsluttet og forankret i DFM's strategi og daglige arbejde.

DFM fik ny direktør den 15. juni 2009, idet DFM's direktør gennem 23 år valgte at trække sig tilbage.

Den nye ledelse har udarbejdet en strategiplan for perioden 2010 - 2012. Der er i strategien lagt stor vægt på at styrke selskabets eksterne netværk med henblik på at øge forståelsen for det danske samfunds nuværende og fremtidige metrologibehov, samt at skabe et stærkt fundament for styrket forskningssamarbejde med universiteter og andre GTS institutter.

Selskabets indsats indenfor de nuværende styrkeområder elektrokemi, akustik, optik og nano-metrologi øges yderligere med særlig fokus på de samfundsrelevante områder sundhed, energi og klima.

DFM's rolle i forhold til Danmarks bidrag til den internationale metrologi vil blive bevaret gennem en fortsat aktiv forskningsindsats. Arbejdet med udvikling af den danske metrologi og metrologistruktur vil fortsætte uændret, blandt andet gennem støtte til Forskning og Innovationsstyrelsens og Sikkerhedsstyrelsens metrologiarbejde samt ved deltagelse i det fælles Metrologiudvalg.

DFM har gennemgået en organisationsændring, og der er indført målstyring og ændrede beslutningskompetencer, således at selskabets struktur og processer på bedre vis støtter den valgte strategi.



Steen Konradsen  
Bestyrelsesformand

På basis af strategiplanen har Videnskabsministeriet godkendt DFM som GTS institut for perioden 2010 - 2012. Der har fra Rådet for Teknologi og Innovations side været stor opbakning til den valgte strategi, idet DFM's resultatkontrakt for de kommende 3 år er øget væsentligt. Det er glædeligt, at der er skabt et solidt grundlag for styrkelse af metrologien i de kommende år til gavn for det danske samfund.

Årets resultat før skat blev - 349 tkr, hvilket overordnet vurderes at være utilfredsstillende. Undskuddet skyldes primært en reduktion i de udenlandske metrologiopgaver, der igennem en årrække har udgjort en væsentlig del af den kommersielle omsætning. Kalibreringsindtægterne, der er en god indikator for metrologibehovet i det danske samfund, udviser fortsat en stabil vækst.

Som led i den nye strategi er der igangsat en række initiativer med det langsigtede formål at øge den kommersielle omsætning indenfor områder af betydning for danske virksomheder og danske myndigheder. Det er således ledelsens forventning, at der kan opnås et positivt resultat for 2010.

Selskabets positive udvikling på forskningssiden er fortsat i 2009, og der er opnået øgede nationale og europæiske bevillinger blandt andet indenfor måling af nanopartikler og anvendelse af elektrokemi i forbindelse med bio-brændstoffer.

Årsrapporten indeholder faktuelle oplysninger om DFM og dansk metrologi som helhed. Den fortæller nogle udvalgte historier, som belyser metrologiens værdi for et moderne samfund, både som støtte til innovation og som en del af samfundets grundlæggende teknologiske infrastruktur.



Michael Kjær  
Adm. Direktør

# MANAGEMENT REPORT 2009

*The following is a translation of an original Danish document. The original Danish document shall be the governing document for all purposes, and in case of any discrepancy the Danish wording shall be applicable.*

Metrology has been a strategic focal point for the Danish Council for Technology and Innovation in the period 2007 to 2009. As a result, new initiatives were launched, which included participation in the European Metrology Research Programme (EMRP), new climate related metrology projects and strengthening of the organisation and international engagement of Danish Metrology.

A new managing director began June 15, 2009 when the previous director chose to retire after 23 years in office.

The new management developed a strategy plan for the period 2010 - 2012. The focus points of the strategy are strengthening DFM's external network thereby increasing the understanding of the current and future metrology needs of the Danish society and to create a strong foundation for increasing research collaboration with Universities and the Advanced Technology Group (GTS).

DFM's research efforts within the primary competence areas electrochemistry, acoustics, optics and nano-metrology will be increased, with particular focus on health, energy and climate change. The contribution to international metrology will continue through DFM's active research effort.

DFM will maintain its support to the development of Danish metrology and metrology infrastructure in collaboration with relevant Danish Authorities.

The organisational structure and the business processes were altered in order to support the new strategy.

Based on the strategy plan the Ministry of Science, Technology and Innovation approved DFM as a member of the Advanced Technology Group (GTS), and our contract with the Danish Council for Technology and Innovation increased substantially.

A solid foundation for Danish metrology has now been established for the benefit of society.

The pre tax accounting income for the year was -349 thousand DKK, which is unsatisfactory. The deficit was mainly caused by a reduction in foreign metrology consultancy tasks, which in previous years made up a substantial part of the revenue. Calibration income continues to show stable growth. As part of the new strategy, initiatives have been launched with the goal of increasing commercial turnover within areas relevant to Danish Industry and Authorities. The management expects that 2010 will show a profit.

The positive development within research continued in 2009 and increased National and European funding was obtained. This includes projects on measurement of nano-particles and use of electrochemistry in relation to bio-fuels.

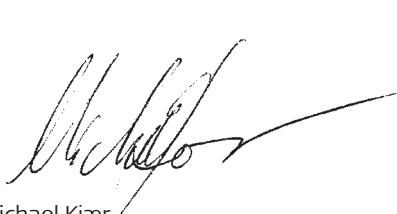
The annual report contains factual information about DFM and Danish metrology and report selected stories highlighting the value of metrology in a knowledge-based society.



Retiring director  
Kim Carneiro greets  
his successor  
Michael Kjær



Steen Konradsen  
Chairman of the Board



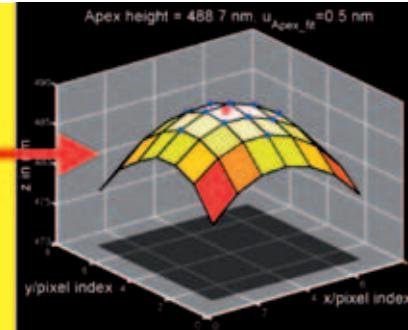
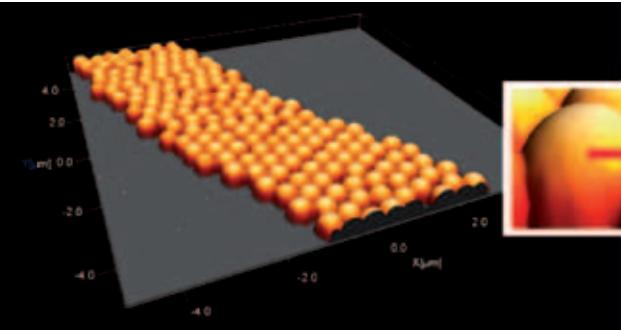
Michael Kjær  
CEO

# NANOPARTICLES – NOW CERTIFIED BY DFM



Bottle containing suspension of nanoparticles with certified diameter.

Dr. Kai Dirscherl extracting a sample of nanoparticles from a reference bottle.



Microscopic image of 500-nm polystyrene particles analysed particle by particle.

**Spherical particles suspended in a liquid are used as a reference material for calibration of particle measurement instruments, which are applied to validate clean rooms in the pharmaceutical and semi-conductor industry. DFM has responded to the needs expressed by several Danish companies and has obtained accreditation for the measurement and certification of particle diameters in such reference materials.**

Particle measurement instruments are typically calibrated with spherical particles of a well known-size; such particles are known as reference particles. These spherical particles are commercially available. However, the average diameter of a batch and the related size distribution reported by the manufacturer is often not well documented, and the traceability of the particle diameter to the meter definition is often missing.

DFM now offers bottles with dispersions of polystyrene particles measured and certified under an accreditation from DANAK, the Danish accreditation body. These bottles contain 15 ml of dispersed particles. The mass concentration of the nanospheres in the dispersion is typically 1%. DFM can offer and certify samples of nanoparticles ranging from 100 nanometre up to 5 000 nanometre in steps of 100 nanometre. The particle diameters can be determined with an expanded uncertainty ranging from 5 nanometre for the smallest up to 50 nanometre for the largest diameters in that range.

The certification is based on three-dimensional images of particle samples obtained with an Atomic Force Microscope (AFM). Each image

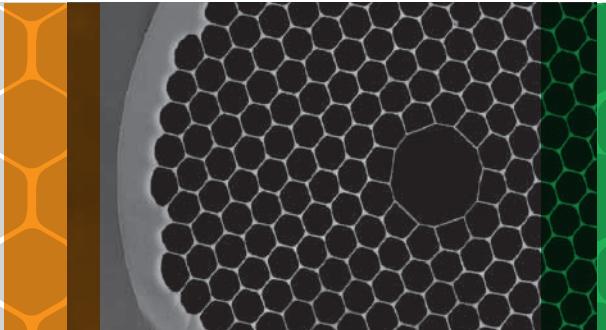
## NANOPARTICLES

Combustion processes, such as those taking place in e.g. car engines or central heating boilers, emit particles, often visible as smoke. Once these airborne particles are smaller than 200 nanometre and have reached the lungs' alveoli, they can enter our bloodstream and cause harm to living tissue. Particle measuring instrumentation, e.g. used in traffic monitoring, needs to be sufficiently accurate in order to correctly detect the harmful smaller particles. Also clean room based production lines rely on an effective surveillance of the particle concentration in order to guarantee high level of product quality.

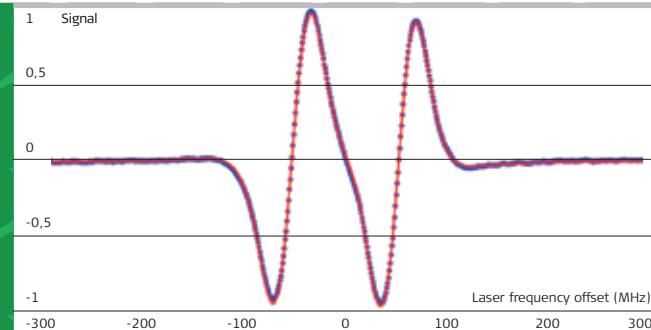
typically contains 100 to 200 particles. In a subsequent image analysis, the particle diameter distribution is calculated. The certified mean particle diameter and its expanded uncertainty follow the diameter distribution along with uncertainty contributions from the measurement method and the process of sampling from the bottle.

The certification of reference particles is the first step at DFM in the establishment of a national primary laboratory for nanoparticle measurements, including particle counting. The importance of such a laboratory has increased rapidly. The exposure to nanoparticles and the related health risks have been pointed out in literature, and as a consequence the need for monitoring nanoparticles in the environment is growing rapidly.

# NEW APPROACH TO HIGH-RESOLUTION SPECTROSCOPY



Cross-section of a hollow core photonic bandgap fibre. NKT Photonics is acknowledged for kind permission to use the image.



Two close-lying absorption lines in ammonia near a wavelength of 1532 nm have been resolved by spectroscopy in a hollow-core fibre. The line shape is a result of the modulation technique applied for increasing the signal-to-noise ratio. The solid red line is a fit to the theoretical line shape.

**DFM has developed new techniques for measuring spectroscopic properties of ammonia molecules. The results add to the existing knowledge about ammonia and have relevance for spectroscopy-based ammonia sensors.**

Ammonia is a naturally occurring gas, which is released for example in connection with pig breeding. In addition, ammonia is produced and used in refrigeration and as feedstock for other nitrogen fertilizers. It is potentially harmful to human health and to the environment, and it is important to have methods for measuring the presence and the quantity of ammonia. One method is spectroscopic measurements, where the interaction between radiation and ammonia molecules is used in quantifying the ammonia concentration. However, such spectroscopic techniques rely on preexisting knowledge about the structure of the molecular spectra. This information does not always exist and the work at DFM contribute to further knowledge.

The techniques developed at DFM use a 3 m long hollow-core photonic bandgap fibre (HC-PBF) filled with ammonia gas. The very thin fibre is designed to guide light at wavelengths around 1500 nm. High intensity is obtained, as the light remains tightly focused while propagating in the narrow fibre core. Thus, the use of the gas-filled fibres provides very efficient interaction between intense light and molecules over long path lengths.

In one experiment, two counter-propagating laser beams are used in the ammonia-filled fibre. The high light intensity results in a phenomenon known as "optical saturation", and detection of

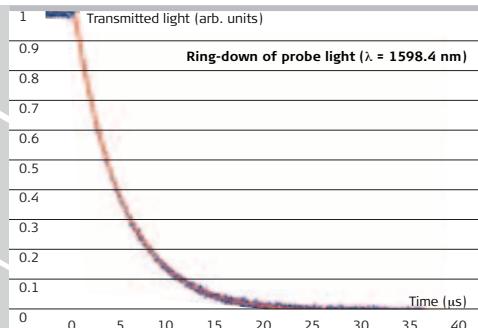
## HOLLOW CORE PHOTONIC BANDGAP FIBRES

A standard optical fibre, which is used in optical telecommunication, has a glass core with a diameter of typically 10 micrometer. A glass cladding of lower density surrounds the core. The light is guided in the core due to the material density difference. In a hollow-core photonic bandgap fibre the glass cladding is replaced by a periodic structure of glass and hollow regions. The core, which has a diameter similar to that of a standard fibre, is hollow as well. The core is normally filled by atmospheric air, but it can be filled with specific gasses. DFM use fibres manufactured by NKT Photonics A/S, a world-leading producer of photonic bandgap fibres.

the optical radiation transmitted through the fibre reveals absorption lines much more narrow than in conventional absorption spectroscopy. New absorption lines in ammonia were identified as a result of the increased resolution.

In a second experiment, DFM places the fibre inside a one-meter long tube guiding microwaves with frequencies around 20 GHz. The simultaneous interaction between microwaves, optical radiation, and ammonia molecules results in so-called microwave-optical double resonance spectra. By measuring the transmitted optical radiation while tuning the microwave- and optical frequencies individually, additional knowledge about ammonia transitions were collected and new assignments of absorption lines were accomplished.

# CAVITY RING-DOWN SPECTROSCOPY FOR TRACE GAS MONITORING



When the laser is switched off, the field inside an optical resonator decays exponentially. The above ring-down curve was recorded using a preliminary test setup at DFM.



Dr. Niels Kjærgaard adjusting the measurement setup

**DFM is extending its spectroscopic facility by introducing a cavity-enhanced technique for high accuracy molecular spectroscopy. The method is very sensitive and suitable for trace gas detection. In addition, it has the unique feature of being able to detect two molecular species simultaneously.**

Conventional laser absorption spectroscopy is a well-established tool for measuring the concentration of specific molecular species. The attenuation of light due to molecular absorption is measured. After passing through the gas the light intensity will decrease with the number of molecules present. For low gas concentrations or short optical path lengths the signal to noise ratio will be poor. However, by placing the gas sample between two mirrors, light can be reflected back and forth many times, effectively increasing the optical path length through the gas. In cavity ring-down spectroscopy, the mirror distance is arranged such that the laser frequency is in resonance with a standing wave between the mirrors in addition to being in resonance with a molecular absorption line. The mirrors are said to form a resonator or a cavity.

When light is coupled into the resonator, optical power will build up as a result of light bouncing back and fourth between the mirrors – more than 10.000 times in the setup implemented at DFM. If the laser light is suddenly turned off, the power in the resonator will decay exponentially with time.

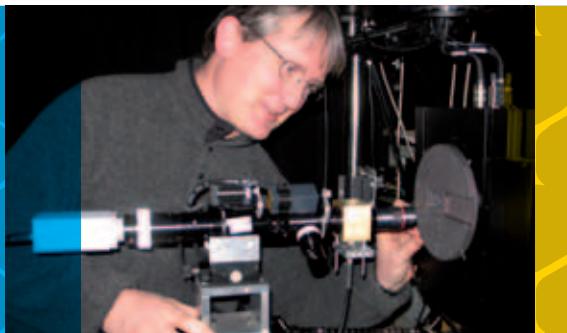
## OPTICAL CAVITY

An optical cavity is a configuration of mirrors forming a standing wave resonator for light. For high reflective mirrors, a photon can travel an effective optical path length of several kilometers, while the cavity has a tractable physical dimension of some centimeters.

This “ring-down” can be monitored by a photodetector. The decay will happen more rapidly if absorbing molecules provide damping. Hence, an accurate determination of the decay time reveals the concentration of absorbing molecules

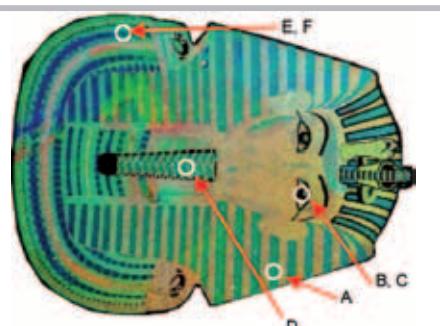
The DFM implementation of cavity ring-down spectroscopy features a novel experimental scheme, where the probe laser frequency is rapidly toggled between two absorbing features and the corresponding ring-down times are recorded. This opens up the possibility of accurately determining the relative abundance of two components of a gas as, e.g., the ratio of  $^{13}\text{CO}_2$  to  $^{12}\text{CO}_2$ . Such ratios are of considerable interest in relation to climate, agriculture, health care and authentication.

# METROLOGY APPLIED TO HOLOGRAMS



Set-up for accurate measurement of the optical appearance of the holograms operated by Dr. Poul-Erik Hansen

Point	Thumbnail	Pitch (nm)	Line amplitude (nm)
A		747 ± 10	~235
C		695 ± 10	~230
D		722 ± 10	~225
E		898 ± 10	~240
F		724 ± 10	~270
B		Roughness ~ 5.2 nm	



**A technique for printing holograms patented by two Danish companies has created a need for a quality control method in which printed holograms are compared with reference holograms. In a joint project with one of the companies, DFM provides the necessary measurement tools.**

Holograms are seen in many places; in particular they appear on credit cards, banknotes and on branded goods, such as CDs, DVDs and software packaging. Holograms serve to make an item stand out visually and to authenticate an item as being genuine. Being virtually impossible to copy, holograms provide a powerful tool against counterfeiting.

Traditionally, surface relief holograms are produced by stamping a nickel hologram master into a thin layer of thermoplastic, which is then mounted on a reflecting aluminium foil. The Danish companies Stensborg A/S and Nilpeter A/S have developed and patented a cassette system, which makes it possible to print holograms directly on paper or foils in a conventional printing process. The process is called HOLOPRINT™.

In order to ensure that the printed holograms meet the expectations of the end users, a new quality control method was requested by the patent owners. In collaboration with Stensborg A/S, DFM has therefore launched a project in which the optical appearance of printed holograms will be compared to that of reference holograms. DFM has built an optical system for recording the optical images of holograms, and methods for comparing such images are being developed.

The small thumbnails in the table are atomic force microscopy images of the grating structure on a nickel hologram master. The actual position of the investigated grating areas A, B, ..., F are marked on the images of the hologram to the right. The period of the different gratings ranges from 695 nm to 747 nm (1000 nm = 1 µm = 0,001 mm) and they have different orientations. The height ranges from 225 nm to 270 nm. One area does not have any grating structure, but the roughness of the surface is approximately 5.2 nm. These quantitative measurements can prove the physical quality of the hologram masters surface.

## MICROSTRUCTURE

The microstructure of a surface relief hologram can be seen in a microscope such as an atomic force microscope (AFM). Each hologram consists of small areas with very fine lines on the surface. The density of the lines is more than one thousand lines per millimetre, and because of this line density the microstructure becomes optically active thus creating a holographic image. Changes in sparkly colours and shapes are seen when the holograms are moved back and forth in ambient light. Copying a hologram is extremely complicated if not impossible.

In a further step of the project, the partner will try to establish a standard for hologram classifications. This will be achieved by correlating the surface relief structure of a master hologram with its optical appearance; especially the influence of defects will be investigated. The local pattern of the master hologram will be measured by atomic force microscopy.

This project is supported by the Danish Agency for Science, Technology and Innovation.

# SELF-CLEANING FLOORS AND WINDOWS

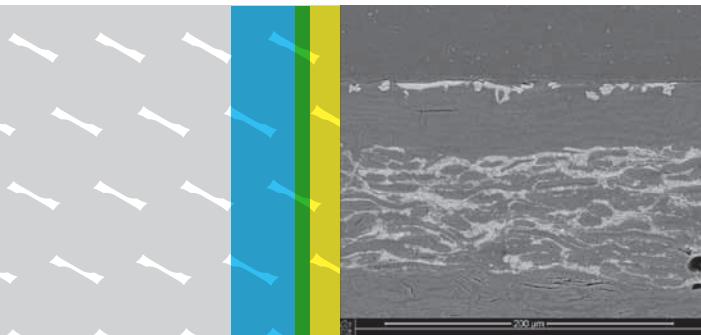


Figure 1: SEM picture showing clusters of titanium oxide in the top layer of a floor sample. It is noticed that the titanium dioxide has formed clusters in the top layer and is not spreading homogeneously over the entire surface layer of the floor as desired.

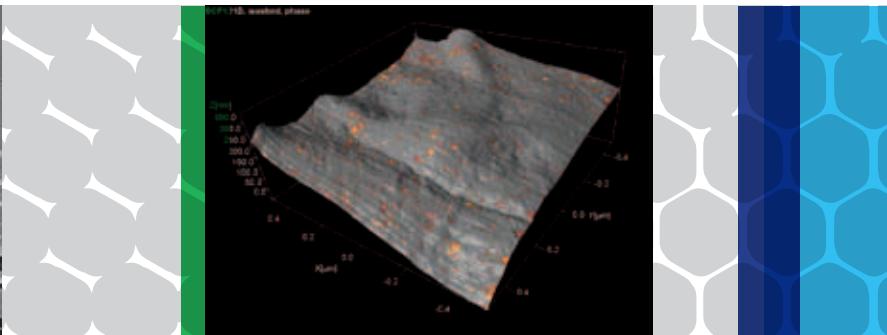


Figure 2: AFM picture showing clusters of titanium oxide in the top layer of a floor sample, orange areas.

**DFM is part of a project concerned with the detailed understanding and improvement of self-cleaning floor and window samples. Adding photocatalytic nano-clusters to conventional samples generates this phenomenon. Measurements require the use of instrumentation suitable for identifying particles at the nano- and micro scale level.**

DFM and FORCE Technology has investigated floor and window samples with the purpose of finding, identifying and measuring the adhesion of active titanium dioxide particles by use of atomic force microscope (AFM) and scanning electron microscope (SEM).

## How does it work?

Floor and window samples have been modified with titanium dioxide, which is a photocatalytic active material. The floor samples are produced by compressing layers of materials, and the photocatalytic material is added to the surface layer. The window samples have had photocatalytic material polished onto the glass.

## Measurement techniques

The AFM, at DFM, is used to measure the shape of the added clusters with high accuracy and also to apply a force to the clusters. The latter is an indication of how strongly the clusters adhere to the surface. It has been found that the binding of the cluster to the surface exceeds the force that could be applied by the AFM. At FORCE Technology the SEM is used for locating the clusters and chemically identify them. A chemical analysis of the samples could identify the presence of titanium and oxygen.

## PHOTOCATALYSIS

Photocatalysis is a phenomenon by which a relatively small amount of light-absorbing material, called a photocatalyst, changes the rate of chemical reaction without itself being consumed. In our case the photocatalyst reacts with water such that water form a perfect film on the surface, which make it easy to remove dirt from the surface.

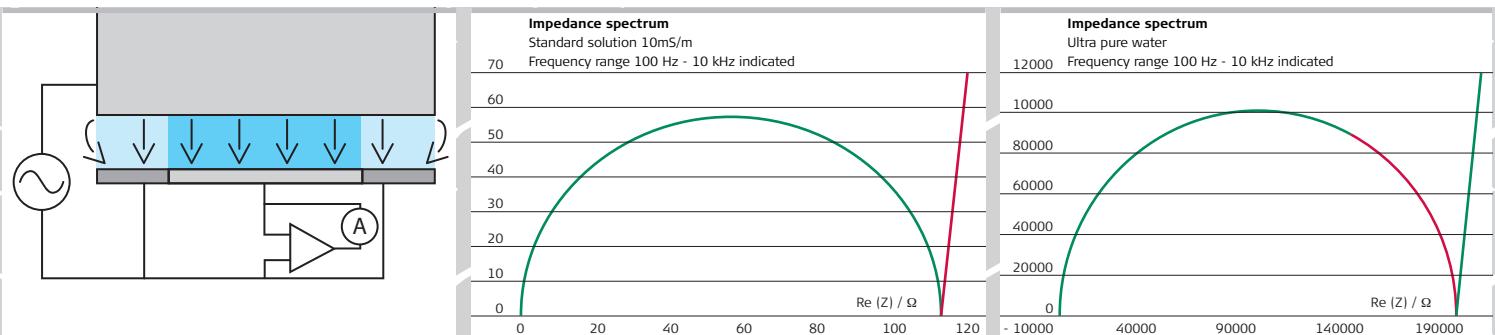
An iterative process consisting of alternate detailed measurements as described and stepwise variation in the sample production has lead to an improved product.

## Further development

The company participating in the project, Photocat, has received valuable insight into the photocatalytic process taking place in the tested floor and window samples and has gained experience in how to improve the production process. The technology will make cleaning of floors and windows much easier. The documented functionality will lower the time of market and entry barrier for the products.

This work has been supported by the Danish Agency for Science, Technology and Innovation through the Innovation Consortia Functional Embedded Nano and Microstructures (FINST).

# ULTRAPURE WATER – HOW PURE IS IT?



A cut-through of a coaxial cell for measurement of ultrapure water. Guard-sections at each end eliminate the stray currents and only the purely radial current in the center-section is measured. Polarisation effects at the electrodes are eliminated by analysing the measured impedance.

## **DFM has designed a new cell for measuring the conductivity of ultrapure water. This is a first step in establishing traceability on measurement of ion activity in clinical chemistry.**

Purity is a measure of the quality of water for a variety of applications: drinking water, water used in food and pharmaceuticals, cooling water and water used in other industrial processes. Requirements to the maximum content of foreign substances, such as salts, depend on the application. As the presence of ions in water increases the conductivity of water dramatically, the conductivity is often used as a measure of the purity of water.

Even the purest water, which does not contain any substances other than H<sub>2</sub>O, has a non-zero conductivity that defines the lower limit on a water purity scale based on conductivity. Unfortunately, the measurement of conductivity of very pure water – also known as ultrapure water – is not fully understood yet. DFM participates in a European Metrology Research Project entitled "Traceable measurements for biospecies and ion activity in clinical chemistry", where one work package is devoted to solving this measurement problem. To measure low levels of ion activity it is necessary to quantify the purity of the water used more precisely.

In a primary measurement, the water conductivity is derived from the impedance versus frequency measured over two electrodes in a measurement cell filled with water. The geometry of the electrodes and the surrounding water defines a cell constant that is used to derive the water conductivity from the measured impedances. DFM has designed a new measurement cell for which the

## **IMPEDANCE**

When a static voltage V is applied over the two ends of a conducting wire, a current I will flow through the wire; this current will be proportional to the voltage, and the constant  $R = V/I$  is called the resistance of the wire. If the wire is cut and two electrodes are inserted, application of a static voltage to this circuit will create a current that vanishes as positive and negative charges are building up on the respective electrodes. If an alternating voltage is applied to the circuit, an alternating current will be generated; the amplitudes of voltage and current will be proportional, but voltage and current will be shifted in time. Mathematically, this fact can be described by the relation  $V/I = Z$ , where V and I are complex numbers describing magnitude and phase of the alternating voltage and current, and where Z is the so-called impedance of the circuit. The real and imaginary parts of  $Z = R + iX$  are called the resistance R, respectively the reactance X of the circuit:  $\text{Re}[Z] = R$ ,  $\text{Im}[Z] = X$ . In general, the impedance of a circuit changes with the frequency of the alternating current. A measured impedance spectrum, i.e. a measurement of impedance versus frequency, can be used to infer useful information about the properties of circuit elements, including a set of electrodes in contact with water.

cell constant has been calculated from its geometry and dimensions. Measurements on ultrapure water with this cell will be used to test different models for the polarisation effect at the water-electrode boundary – an effect that is necessary to better understand how to achieve the precision required when measuring conductivity of ultrapure water in the presence of low level ionic contamination.

The project is co-funded by the Danish Council for Technology and Innovation, and the European Commission under Grant Agreement No. 217257.

# SETTING THE STRATEGY FOR EUROPEAN NANOMETROLOGY



Partners in the EU-supported project Co-Nanomet

Co-founder and Sales Manager Dr. Anders Blom from QuantumWise is giving a talk at the European Nanometrology Workshop 19th to 20th November 2010, Braunschweig, Germany, co-organized by DFM. The workshop brought together over 140 leading experts from industry, research institutes, national metrology institutes and regulatory bodies to review the current state of the art and the future metrology needs of European Nanotechnology Industry.

**DFM is taking a leading part in formulating the long term strategy for nanometrology in Europe. Fourteen partners within the EU-supported project Co-Nanomet have expressed the needs for a coordinated nanometrology in the member states and have analysed the current strengths and weaknesses of the supporting metrology.**

The European Commission launched the Framework Program 7 (FP7) named "Coordination Action" in 2008. Funded by this program, the pan-European project "Co-Nanomet" was initiated in 2009. The purpose of Co-Nanomet is to establish a coordinated European strategy for metrology at the nano-scale in support to science, innovation and technology. The European Society for Precision Engineering and Nanotechnology, euspen, is the leading partner, seconded by DFM. The Co-Nanomet consortium is made up of fourteen expert organisations in the fields of nanometrology, nanotechnology, technology transfer and specialised training with a geographical distribution as illustrated above. The project period covers 2009-2010.

A milestone achieved in the first year was the report "Nanometrology strategy paper". Based on the input from a questionnaire sent to more than 30 international expert organisations, it covers topics such as the current status, capabilities and limitations of state-of-the-art techniques and instrumentation. Together with the projected future needs in the field of nanometrology, a strategy is defined. DFM played a key role during the process of fact finding and strategy formulation.

Another core activity of Co-Nanomet is the formation of five European Nanometrology Action Groups. Their aim is to address the need for the establishment of a coordinated dissemination of metrology techniques to industry. Under this process, the traceability to internationally recognised national standards must be maintained. The action groups are formed around the most challenging topics in nanometrology today: Engineered nanoparticles, Nanobiotechnology, Thin films and structured surfaces, Critical dimension and scanning probe techniques, and Modelling and simulation.

On invitation from DFM, The Danish nanotechnology company QuantumWise A/S participates in the Co-nanomet action group on Modelling and Simulation at the Nanoscale. QuantumWise A/S was founded in 2008 by CEO Dr. Kurt Stokbro. The company develops and sells the software package "Atomistix ToolKit", a point-and-click program for simulation and analysis of physical and chemical properties of nanoscale devices. "QuantumWise sees the activity as important for defining the future nanotechnology activity across Europe and would like to see that the area is properly covered", says co-founder Dr. Anders Blom.

# ÅRSREGNSKAB FOR PERIODEN 2009-01-01 TIL 2009-12-31

## LEDELSESPÄTEGNING

Bestyrelse og direktion har dags dato behandlet og godkendt årsrapporten for regnskabsåret 1. januar 2009 - 31. december 2009 for Dansk Fundamental Metrologi A/S.

Årsrapporten er aflagt i overensstemmelse med Årsregnskabsloven.

Det er vores opfattelse, at årsregnskabet giver et retvisende billede af Dansk Fundamental Metrologi A/S' aktiver, passiver og finansielle stilling pr. 31. december 2009 samt af resultatet af selskabets aktiviteter og pengestrømme for regnskabsåret 1. januar - 31. december 2009.

Det er endvidere vores opfattelse, at ledelsesberetningen indeholder en retvisende redegørelse for de forhold beretningen omhandler.

Årsrapporten indstilles til generalforsamlingens godkendelse.

Kgs. Lyngby, den 24. marts 2010

## DIREKTION



Michael Kjær  
Direktør

## BESTYRELSE



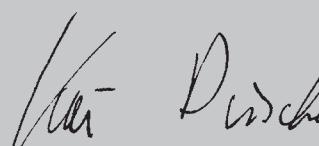
Lars Barkler



Knut Conradsen  
Næstformand



René Logie Damkjær



Kai Dirscherl  
Medarbejderrepræsentant



Steen Konradsen  
Formand



Jan Conrad Petersen  
Medarbejderrepræsentant



Søren Stjernqvist

# REVISIONSPÅTEGNING

## DEN UAFHÆNGIGE REVISORS PÅTEGNING

### Til aktionæren i Dansk Fundamental Metrologi A/S

Vi har revideret årsregnskabet for Dansk Fundamental Metrologi A/S for regnskabsåret 1. januar - 31. december 2009, side 15-19. Årsregnskabet omfatter anvendt regnskabspraksis, resultatopgørelse, balance, pengestrømsopgørelse og noter. Årsregnskabet udarbejdes efter årsregnskabsloven.

Vi har i tilknytning til revisionen gennemlæst ledelsesberetningen, der udarbejdes efter årsregnskabsloven, og afgivet udtalelse herom.

### Ledelsens ansvar

Ledelsen har ansvaret for at udarbejde og aflægge et årsregnskab, der giver et retvisende billede i overensstemmelse med årsregnskabsloven. Dette ansvar omfatter udformning, implementering og opretholdelse af interne kontroller, der er relevante for at udarbejde og aflægge et årsregnskab, der giver et retvisende billede uden væsentlig fejlinformation, uanset om fejlinformationen skyldes besvigelser eller fejl, samt valg og anvendelse af en hensigtsmæssig regnskabspraksis og udøvelse af regnskabsmæssige skøn, som er rimelige efter omstændighederne. Ledelsen har endvidere til ansvar at udarbejde en ledelsesberetning, der indeholder en retvisende redegørelse i overensstemmelse med årsregnskabsloven.

### Revisors ansvar og den udførte revision

Vores ansvar er at udtrykke en konklusion om årsregnskabet på grundlag af vores revision. Vi har udført vores revision i overensstemmelse med danske revisionsstandarder og god offentlig revisionsskik jf. revisionsinstruks for revisor ved Godkendte Teknologiske Serviceinstitutter (GTS). Disse standarder kræver, at vi lever op til etiske krav samt planlægger og udfører revisionen med henblik på at opnå høj grad af sikkerhed for, at årsregnskabet ikke indeholder væsentlig fejlinformation.

En revision omfatter handlinger for at opnå revisionsbevis for de beløb og oplysninger, der er anført i årsregnskabet. De valgte handlinger afhænger af revisors vurdering, herunder vurderingen af risikoen for væsentlig fejlinformation i årsregnskabet, uanset om fejlinformationen skyldes besvigelser eller fejl. Ved risikovurderingen overvejer revisor interne kontroller, der er relevante for selskabets udarbejdelse og aflæggelse af et årsregnskab, der giver et retvisende billede, med henblik på at udforme revisionshandlinger, der er passende efter omstændighederne, men ikke med det formål at udtrykke en konklusion om effektiviteten af selskabets interne kontrol. En revision omfatter endvidere stillingtagen til, om den af ledelsen anvendte regnskabspraksis er passende, om de af ledelsen udøvede regnskabsmæssige skøn er rimelige samt en vurdering af den samlede præsentation af årsregnskabet.

Det er vores opfattelse, at det opnåede revisionsbevis er tilstrækkeligt og egnet som grundlag for vores konklusion.

Revisionen har ikke givet anledning til forbehold.

### Konklusion

Det er vores opfattelse, at årsregnskabet giver et retvisende billede af selskabets aktiver, passiver og finansielle stilling pr. 31. december 2009 samt af resultatet af selskabets aktiviteter og pengestrømme for regnskabsåret 1. januar - 31. december 2009 i overensstemmelse med årsregnskabsloven.

### Udtalelse om ledelsesberetningen

Vi har i henhold til årsregnskabsloven gennemlæst ledelsesberetningen. Vi har ikke foretaget yderligere handlinger i tillæg til den gennemførte revision af årsregnskabet. Det er på denne baggrund vores opfattelse, at oplysningerne i ledelsesberetningen er i overensstemmelse med årsregnskabet.

København, den 24. marts 2010  
KPMG, Statsautoriseret Revisionspartnerselskab



Peter Gath, statsaut. revisor



Charlotte Formsgaard, statsaut. revisor

# ANVENDT REGNSKABSPRAKSIS

## Generelt

Årsrapporten for Dansk Fundamental Metrologi A/S (DFM) for 2009 er aflagt i overensstemmelse med årsregnskabslovens bestemmelser for klasse B-virksomheder. Herudover har selskabet frivilligt tilvalgt følgende regler for klasse C-virksomheder:

- + Aflæggelse af ledelsesberetning.
- + Udarbejdelse af pengestrømsopgørelse.

Årsregnskabet er aflagt efter samme regnskabspraksis som sidste år. Regnskabet er baseret på selskabets bogføring, men tallene er angivet i tusinde af kroner. Der kan derfor forekomme tilsyneladende afrundningsfejl ved sammentællingerne.

## Omregning af fremmed valuta

Transaktioner i fremmed valuta omregnes til transaktionsdagens kurs. Valutadifferencer, der opstår mellem transaktionsdagens kurs og kurset på betalingsdagen, indregnes i resultatopgørelsen som en finansiel post. Tilgodehavender, gæld og andre monetære poster i fremmed valuta omregnes til balancedagens valutakurs. Forskellen mellem balancedagens kurs og kurset på tidspunktet for tilgodehavendets eller gældens opstæn indregnes i resultatopgørelsen under finansielle indtægter og omkostninger.

## RESULTATOPGØRELSEN

### Indtægter

Indtægter fra forskningskontrakter indregnes i takt med at arbejdet udføres, hvorved nettoomsætningen svarer til salgsværdien af årets udførte arbejder (produktionsmetoden). Nettoomsætningen indregnes, når de samlede indtægter og omkostninger på forskningskontrakten og færdiggørelsесgraden på balancedagen kan opgøres pålideligt, og det er sandsynligt, at de økonomiske fordele, herunder betalinger, vil tilgå selskabet. I projekter, hvor DFM er tilskudsmottager på vegne af et konsortium, indregnes tilskudsbeløbet som omsætning, i det omfang DFM på vegne af konsortiet er økonomisk ansvarlig over for tilskudsgiver; partneres omkostninger fradrages i udlæg. I projekter hvor DFM ikke er ansvarlig for partneres ydelser indregnes kun den forholdsmaessige andel af kontraktsummen, som direkte tilfaller DFM, i omsætningen. Indtægter fra resultatkontraktaktiviteter indtægtsføres i det år tilskuddene modtages, som er sammenfaldende med den tilladte anvendelsesperiode.

### Skat af årets resultat

Årets skat, som består af årets aktuelle skat og forskydning i udskudt skat, indregnes i resultatopgørelsen med den del, der kan henføres til årets resultat, og direkte i egenkapitalen med den del, der kan henføres til bevægelser direkte i egenkapitalen.

## BALANCEN

### Materielle anlægsaktiver

Materielle anlægsaktiver måles til kostpris med fradrag af akkumulerede afskrivninger. Afskrivningsgrundlaget er kostpris med fradrag af forventet restværdi efter afsluttet brugstid. Kostprisen omfatter anskaffelsesprisen samt omkostninger direkte tilknyttet anskaffelsen indtil det tidspunkt, hvor aktivet er klar til brug.

Udstyr og inventar afskrives lineært over 3-7 år til en restværdi på 0-20% af anskaffelsesprisen. I anskaffelsesåret afskrives for et helt år uanset anskaffelsestidspunktet.

Indretning af lejede lokaler afskrives lineært baseret på aktivernes forventede brugstid, der regnes som 15 år fra 2002.

Udstyr og inventar overdraget 1. januar 2006 fra den selvejende institution Dansk Institut for Fundamental Metrologi afskrives med en særlig afskrivningsprofil over 6 år til en restværdi på 20%.

Anskaffelser med en anskaffelsessum på under 20 000 kr., udstyr anskaffet for offentlige tilskudsmidler samt mindre kontorinventar indregnes i resultatopgørelsen i anskaffelsesåret. Fortjeneste eller tab ved afhændelse af materielle anlægsaktiver opgøres som forskellen mellem salgspris med fradrag af salgsomkostninger og den regnskabsmæssige værdi på salgstidspunktet. Fortjeneste eller tab indregnes i resultatopgørelsen under afskrivninger.

#### **Igangværende arbejder**

Igangværende arbejder for fremmed regning måles til salgsværdien af det udførte arbejde omfattende medgået tid samt afholdte udlæg. Salgsværdien måles på baggrund af færdiggørelsесgraden på balancedagen og de samlede forventede indtægter på det enkelte igangværende arbejde.

Når salgsværdien på en forskningskontrakt ikke kan opgøres pålideligt, måles salgsværdien til de medgåede omkostninger eller nettorealisationsværdien, såfremt denne er lavere. Det enkelte igangværende arbejde indregnes i balancen under tilgodehavender eller gældsforpligtelser afhængig af nettoværdien af salgssummen med fradrag af àconto faktureringer og forudbetalingen. Omkostninger i forbindelse med salgsarbejde og opnåelse af kontrakter indregnes i resultatopgørelsen i takt med, at de afholdes.

#### **Tilgodehavender**

Tilgodehavender måles til amortiseret kostpris. Der nedskrives til imødegåelse af forventede tab efter en individuel vurdering af tilgodehavender.

#### **Selskabsskat og udskudt skat**

Aktuelle skatteforpligtelser og tilgodehavende aktuel skat indregnes i balancen som beregnet af årets skattepligtige indkomst, reguleret for skat af tidligere års skattepligtige indkomster samt for betalte acontoskatter.

Udskudt skat måles efter den balanceorienterede gældsmetode af alle midlertidige forskelle mellem regnskabsmæssige og skattemæssig værdi af aktiver og forpligtelser.

Udskudte skatteaktiver, herunder skatteværdien af fremførselsberettigede skattemæssige underskud, måles til den værdi, hvortil de forventes at kunne realiseres, enten ved udлиниing i skat af fremtidig indtjening eller ved modregning i udskudte skatteforpligtelser inden for samme juridiske skatteenhed. Eventuelle udskudte nettoaktiver måles til nettorealisationsværdi.

Udskudt skat måles på grundlag af de skatteregler og skattesatser, der med balancedagens lovgivning vil være gældende, når den udskudte skat forventes udløst som aktuel skat. Ændring i udskudt skat som følge af ændringer i skattesatser indregnes i resultatopgørelsen.

#### **Pengestrømsopgørelse**

Pengestrømsopgørelsen viser selskabets pengestrømme fordelt på drifts-, investerings- og finansieringsaktivitet for året, årets forskydning i likvider samt selskabets likvider ved årets begyndelse og slutning.

# RESULTATOPGØRELSE OG BALANCE

## RESULTATOPGØRELSE (tkr.)

<b>Noter</b>		<b>2009</b>	<b>2008</b>
	Kundeomsætning	2 504	3 023
	Projektomsætning	2 249	2 221
	Resultatkontrakt	13 356	11 560
	<b>Nettoomsætning i alt</b>	<b>18 109</b>	<b>16 804</b>
	Projektpartnere	234	228
	Rejseomkostninger	461	478
	Andre udlæg	649	1 136
	<b>Udlæg i alt</b>	<b>1 344</b>	<b>1 842</b>
1	<b>Bruttoresultat</b>	<b>16 765</b>	<b>14 962</b>
2	Personaleomkostninger	12 254	10 703
	Andre eksterne omkostninger	3 820	2 847
	<b>Omkostninger i alt</b>	<b>16 074</b>	<b>13 550</b>
	<b>Resultat før afskrivninger</b>	<b>691</b>	<b>1 412</b>
3	Af- og nedskrivninger af materielle anlægsaktiver	1 250	1 190
	<b>Resultat før finansielle poster</b>	<b>( 560)</b>	<b>222</b>
	Finansielle indtægter	218	307
	Finansielle omkostninger	7	5
	<b>Resultat før skat</b>	<b>( 349)</b>	<b>524</b>
	Skat af årets resultat	0	0
	<b>Årets resultat</b>	<b>( 349)</b>	<b>524</b>
	Årets resultat overføres til næste år.		

## BALANCE PR. 31 DECEMBER (tkr.)

<b>Noter</b>	<b>AKTIVER</b>	<b>2009</b>	<b>2008</b>
	Deposita	372	372
	<b>Finansielle anlægsaktiver i alt</b>	<b>372</b>	<b>372</b>
	Udstyr og inventar	3 784	3 510
	Indretning af lejede lokaler	2 341	2 643
3	<b>Materielle anlægsaktiver i alt</b>	<b>6 125</b>	<b>6 153</b>
	<b>Anlægsaktiver i alt</b>	<b>6 497</b>	<b>6 525</b>
4	<b>Igangværende arbejder for fremmed regning</b>	<b>1 143</b>	<b>1 414</b>
	Tilgodehavender fra salg og tjenesteydelser	895	1 985
	Andre tilgodehavender	107	54
	<b>Tilgodehavender i alt</b>	<b>1 002</b>	<b>2 039</b>
	<b>Likvide midler</b>	<b>7 576</b>	<b>6 589</b>
	<b>Omsætningsaktiver i alt</b>	<b>9 722</b>	<b>10 042</b>
	<b>Aktiver i alt</b>	<b>16 219</b>	<b>16 568</b>
	<b>PASSIVER</b>	<b>2009</b>	<b>2008</b>
	Aktiekapital	1 000	1 000
	Overført resultat	11 880	12 228
5	<b>Egenkapital i alt</b>	<b>12 880</b>	<b>13 228</b>
	Forudbetalinger fra kunder og bevillingsgivere	656	217
	Kreditorer og skyldige omkostninger	1 084	1 775
	Gæld til modervirksomhed	188	0
	Anden gæld	1 411	1 348
	<b>Kortfristet gæld i alt</b>	<b>3 339</b>	<b>3 339</b>
	<b>Passiver i alt</b>	<b>16 219</b>	<b>16 568</b>
6	Eventualforpligtelser		

# PENGESTRØMSOPGØRELSE

## PENGESTRØMSOPGØRELSE ( tkr. )

	<b>2009</b>	<b>2008</b>
<b>Noter</b>		
Periodens resultat før renter og afskrivninger	691	1 412
Ændring i igangværende arbejder for fremmed regning	271	975
Ændring i tilgodehavender fra salg og tjenesteydelser	1 090	( 1 484)
Ændringer i andre tilgodehavender og periodeafgrænsningsposter	( 53)	131
Ændring i kortfristede gældsforspligtelser	0	1 031
<b>Pengestrømme fra driften</b>	<b>1 999</b>	<b>2 066</b>
 3 Køb og salg af materielle anlægsaktiver	( 1 222)	( 547)
<b>Pengestrøm fra investeringsaktivitet</b>	<b>( 1 222)</b>	<b>( 547)</b>
 Renteindtægter og -omkostninger	211	302
<b>Pengestrøm fra finansieringsaktivitet</b>	<b>211</b>	<b>302</b>
 <b>Periodens likviditetsforskydning</b>	<b>988</b>	<b>1 821</b>
 Likvide beholdninger primo	6 588	4 767
<b>Likvide beholdninger ultimo</b>	<b>7 576</b>	<b>6 588</b>

# NOTER

1 Efterkalkulerede egenfinansierede forsknings- og udviklingsomkostninger er opgjort til 613 tkr.  
(2008: 607 tkr.)

		2009	2008
2	<b>Personaleomkostninger (tkr.)</b>		
	Løn og gager	12 059	10 583
	Pensioner	55	0
	Andre omkostninger til social sikring	140	119
	<b>Personaleomkostninger i alt</b>	<b>12 254</b>	<b>10 703</b>

DFM har i 2009 i gennemsnit beskæftiget 20 medarbejdere opgjort efter antal årsværk (2008: 18). Løn og gager indeholder vederlag til direktionen og bestyrelseshonorar.

3 Materielle anlægsaktiver (tkr.)

Anskaffelsessum	Udstyr og Inventar	Indretning af lokaler	Arkivalier	I alt
Saldo 2009-01-01	6 242	3 549	760	10 551
Tilgang	1 223	0	0	1 223
Afgang	26	0	0	26
Saldo 2009-12-31	7 439	3 549	760	11 748
<b>Afskrivninger</b>				
Saldo 2009-01-01	2 732	906	760	4 398
Afskrivninger	949	302	0	1 251
Afskrivninger, afhændede aktiver	26	0	0	26
Saldo 2009-12-31	3 655	1 208	760	5 623
<b>Bogført værdi</b>	<b>3 784</b>	<b>2 341</b>	<b>0</b>	<b>6 125</b>
Vinding ved køb/salg	1	0	0	1
<b>Årets Afskrivning i alt</b>	<b>948</b>	<b>302</b>	<b>0</b>	<b>1 250</b>

		2009	2008
4	<b>IGANGVÆRENDE ARBEJDER FOR FREMMED REGNING (tkr.)</b>		
	Offentlige danske institutioner	602	397
	Udenlandske institutioner	541	1 016
	Danske virksomheder	0	0
	<b>IGANGVÆRENDE ARBEJDER I ALT</b>	<b>1 143</b>	<b>1 414</b>

		Aktiekapital	Overført resultat	I alt
5	Egenkapital (tkr.)			
	Egenkapital 2009-01-01	1 000	12 228	13 228
	Årets resultat		( 349)	( 349)
	<b>Egenkapital i alt</b>	<b>1 000</b>	<b>11 880</b>	<b>12 880</b>

Der er udstedt 1 000 000 aktier med pålydende værdi på 1 kr.

## Ejerforhold

Følgende aktionær ejer hele aktiekapitalen:

Danmarks Tekniske Universitet  
Anker Engelundsvej 1  
Bygning 101A  
2800 Kgs. Lyngby

6 Eventualforpligtelser

Selskabet har en lejeforpligtelse vedrørende lejemål med en opsigelsesperiode på op til 12 måneder, svarende til 839 tkr. (2008: 808 tkr.)

# ACCOUNTS OF PARTICULAR ACTIVITIES



## Participation in committees and working groups under the Metre Convention and EURAMET

- + Comité International des Poids et Mesures (CIPM)
- + EMRP Committee
- + Consultative Committee for Electricity and Magnetism (CCEM)
- + Consultative Committee for Amount of Substance (CCQM)
- + Consultative Committee for Acoustics, Ultrasound and Vibration (CCAUV)
- + EURAMET Technical Committee for Mass (TC-M)
- + EURAMET Technical Committee for Electricity and Magnetism (TC-EM)
- + EURAMET Technical Committee for Length (TC-L)
- + EURAMET Technical Committee for Photometry and Radiometry (TC-PR)
- + EURAMET Technical Committee for Acoustics, Ultrasound and Vibration (TC-AUV)
- + EURAMET Technical Committee for Time and Frequency (TC-TF)
- + EURAMET Technical Committee for Interdisciplinary Metrology (TC-IM)
- + EURAMET Technical Committee for Quality (TC-Q)
- + BIPM Director's ad hoc Advisory Group on Uncertainty
- + Joint Committee on Guides in Metrology – Working Group 1, Guide to the expression of uncertainty in measurement (JCGM-WG1)
- + Consultative Committee for Length – Working Group on Dimensional Metrology – Discussion Group on Nanometrology (CCL-WGDM-DG7)
- + Consultative Committee for Amount of Substance – Working Group on Electrochemical Analysis (CCQM – EAWG)
- + Consultative Committee for Mass and Related Quantities – Working Group on Changes to the SI kilogram (CCM-WGS1-kg)
- + Consultative Committee for Mass and Related Quantities – Working Group on Mass Standards – Task Group 2; Uncertainty components due to traceability to the international prototype of the kilogram (CCM-WGM-TG2)

## Participation in national and international projects

- + Centre for industrial nano optics (CINO), RTI
- + Functional materials with embedded nano structures (FINST), RTI

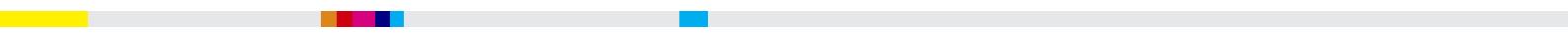
- + Determination of the Boltzmann constant for the redefinition of the kelvin, EMRP/RTI
- + Breath analysis as a diagnostic tool for early disease detection, EMRP/RTI
- + Traceable measurements for biospecies and ion activity in clinical chemistry, EMRP/FI
- + Measurement of size and shape of aerosols, FI
- + Centre of excellence for acoustic metrology, FI
- + Improving measurement of electrical power quality, FI
- + Quantitative measurement of atmospheric molecules, FI
- + Printed holograms – Basic properties, RTI
- + Coordination of nanometrology in Europe (Co-Nanomet), EU

## Calibration certificates and measurement reports

+ DC electricity	6
+ Electrochemistry	200
+ Mass	16
+ Length	10
+ Optical radiometry	20
+ Nano structures	4
+ Acoustics	7
+ Total	263

## Publications 2009

- + N. Tabrizian, P.E. Hansen og H.N. Hansen  
Optical characterization of turned and anodized aluminium  
Proceedings of the euspen International Conference,  
San Sebastian, June 2009. ISBN 13: 978-0-9553082-6-0  
DFM-2009-P01
- + Salvador Barrera Figueroa,  
Knud Rasmussen and Finn Jakobsen  
Hybrid method for determining the parameters of condenser microphones from measured membrane velocities and numerical calculations, Journal of Acoustic Society of America 126 (2009) 1788-1795  
DFM-2009-P02
- + P.-E. Hansen and L. Nielsen  
Combined optimization and hybrid scalar-vector diffraction method for grating topographyparameters determination  
Materials Science & Engineering B 165 (2009) 165-168  
DFM-2009-P03
- + P. Morgen, B.O. Henriksen, D. Kyrpeling, T. Sørensen, Y.X. Yong, J. HolstJ.R. Aelsen and P.E. Hansen  
Examples of Current Industrial Micro- and Nanomaterials and Techniques for their Characterization  
Nanostructured Materials for Advanced Technological Applications, NATO Science for Peace and Security Series B: Physics and Biophysics, Volume. ISBN 978-1-4020-9915-1.  
Springer Netherlands, (2009), 103-113  
DFM-2009-P04

- 
- + Steffen Seitz, Petra Spitzer,  
Pia T. Jakobsen and Hans D. Jensen  
Metrological Traceability Concept for  
Electrolytic Conductivity and pH  
CHIMIA 63 (2009) 640-642  
DFM-2009-P05
- DFM Reports 2009**
- + DFM Årsrapport 2008  
DFM-2009-R01
- + Poul Erik Hansen  
ODM analyse af begravede strukturer  
DFM-2009-R02
- + Kai Dirscherl  
Euramet 1027 – Calibration particles measured  
with an AFM  
DFM-2009-R03
- + Kim Carneiro, Hans Dalsgaard Jensen, Preben Howarth  
og Isabella Stendal.  
Faglig rapportering til Rådet for Teknologi og Innovation  
2008  
DFM-2009-R04
- + Kim Carneiro, Gunnar Østergaard, Kaj Bryder og  
Jørgen Duvald Christensen  
Faglig rapport 2008: Styrket international deltagelse  
og organisering af dansk metrologi  
DFM 2009-R05
- + Kai Dirscherl  
Metrologic validation of aerosol measurement methods  
DFM-2009-R06
- + Salvador Barrera Figueroa  
Dansk Primærlaboratorium for Akustik  
Årsrapport 2008  
DFM-2009-R07
- + Jan Hald, Lars Nielsen og Jan C. Petersen  
An acetylene stabilised fibre laser  
DFM-2009-R08
- + C.I. Falk, J. Hald, J.C. Petersen and K. Rotwitt  
Enhanced nonlinear interactions in liquid-filled  
photonic crystal fibres  
DFM-2009-R09
- + Kim Carneiro, Salvador Barrera Figueroa,  
Knud Rasmussen, Erling S. Olsen, Erling Frederiksen,  
Torben Licht og Ole Esben Sørensen  
Handlingsplan for metrologi inden for Akustik,  
Ultralyd og Vibration  
DFM-2009-R10
- + Salvador Barrera Figueroa og Erling Frederiksen  
Measurement of the front cavity of laboratory  
standard microphones  
DFM-2009-R11
- + Michael Kjær, Hans D. Jensen og Jan C. Petersen  
Strategiplan for perioden 2010-2012  
Metrologi som grundlag for vækst  
DFM-2009-R12
- + Kai Dirscherl  
Comparison of an AFM method for the measurement  
of nanoparticle diameter with NIST-traceable reference  
material  
DFM-2009-R13
- + Kim Carneiro, Enrico Canuto, Marco dell'Isola, Settimio  
Mobilio Giuseppina Rinaudo and Alberto Dal Poz  
Evaluation of Istituto Nazionale di Ricerca Metrologica 2008  
Evaluation of INRIM 2008  
DFM-2009-R14
- + Kim Carneiro  
Finansieringen af metrologisk udstyr  
DFM-2009-R15
- + Preben Howarth  
AL 08 IB FI 05  
Strengthening of the national metrology infrastructure  
and achievement of international recognition.  
Afsluttende rapport Tilskud til dansk deltagelse i EU's  
twinning programmer (FINS)  
DFM-2009-R16
- + Salvador Barrera-Figueroa, Lars Nielsen, Knud Rasmussen  
Andrés E. Pérez Matzumoto and José Noé Razo Razo  
Report on the Key Comparison CCAUV.A-K4 Draft B  
DFM-2009-R17
- + Preben Howarth  
Rapportering af formidling fra danske kontaktpersoner 2009  
DFM-2009-R18
- + Kai Dirscherl, Jørgen Garnæs og Lars Nielsen  
Interlaboratory comparisons 2007, Metrology –  
Mass, final report  
DFM-2009-F01
- + Kai Dirscherl, Jørgen Garnæs og Lars Nielsen  
Interlaboratory comparisons 2007, Metrology –  
Length, final report  
DFM-2009-F02
- + Kai Dirscherl  
Udmåling af en linsemaster  
DFM-2009-F03
- + Jørgen Garnæs  
Forundersøgelse af cylinderformede mikrolinser  
støbt i plastik med atomic force mikroskopi  
DFM-2009-F04
- + Hans D. Jensen og Pia Tønnes Jakobsen,  
(Draft A) Report on CCQM P83 – measurement of  
low conductivity  
DFM-2009-F05
- + Kim Carneiro  
Developing Metrology in Chemistry in Peru, with special  
attention to drinking water  
DFM-2009-F06

- 
- + Jørgen Garnæs  
Cemecon: Undersøgelse af prøver med belægning  
DFM-2009-F07
- + Jørgen Garnæs  
Investigation of NIL test samples  
DFM-2009-F08
- Reports in series F are confidential
- Contribution at conferences and monographs**
- + Vicente Cuitanda-Henriquez, Peter Møller Juhl,  
Salvador Barrera-Figueroa  
Numerical design and testing of a sound source for  
secondary calibration of microphones using the  
Boundary Element Method  
NAG/DAGA 2009, Rotterdam, The Netherlands,  
March 23-26, 2009.
- + J. Garnæs, K. Dirscherl, J. Hald, J. Henningsen,  
K. E. Johansson  
Sub-nanometer accurate atomic force microscopy  
over 0.5 nm (Poster)  
NanoDay 2009 – Joint meeting between Nano DTU,  
Nano-Science Center, NanoTUM and TU/e and Technical  
University of Denmark  
Kgs. Lyngby, Denmark, May 6, 2009
- + Jan Hald, Lars Nielsen og Jan C. Petersen  
A spectroscopic determination of the Boltzmann constant  
(Poster) CLEO/Europe-EQEC  
Munich, Germany, June 15-19, 2009
- + Salvador Barrera-Figueroa, Marta Diaz-Ben, Finn Jacobsen  
Pressure calibration of measurement microphones in a  
free field  
Internoise 2009  
Ottawa, Canada, August 2009.
- + Lars Nielsen, Jan Hald, Jan C. Petersen  
Evaluation of the Boltzmann constant from  
Doppler broadened absorption spectra  
IV International Workshop on Progress in  
Determining the Boltzmann Constant  
Torino, Italy, September 22-24, 2009
- Other talks**
- + Jørgen Garnæs  
Ultra precise nanometer scale measurements  
lecture in course 10030 Physics and Nanotechnology  
and practical exercise for two students (2009)  
The Technical University of Denmark, January 8, 2009
- + Jan Hald, Kai Dirscherl  
Kursus i validering af software til laboratoriebrug  
DFM, 22-23 Januar 2009
- + Jørgen Garnæs  
Gauge block calibration – Demonstration on  
primary optical techniques lecture in course 42215 –  
Geometrical metrology and machine testing  
The Technical University of Denmark, April 15, 2009
- + Jan Hald, Kai Dirscherl  
Kursus i validering af software til laboratoriebrug,  
Statens Serum Institut, 21-22 April 2009
- + Jan Hald, Jan C. Petersen, Lars Nielsen  
Experimental progress, Boltzmann WP4 meeting  
Caserta, Italy, April 28, 2009
- + Lars Nielsen, Jan Hald  
The Boltzmann project – Evaluation of measurement data  
Boltzmann WP4 meeting  
Caserta, Italy, April 28, 2009
- + Jan Hald, Jørgen Garnæs, Lars Nielsen  
Foredrag om metrologi samt rundvisning for  
elever fra Nærumb Gymnasium  
DFM, May 4, 2009
- + Lars Nielsen  
Evaluation of key comparisons using the method of least  
squares, 2nd Meeting of ICAC-2009 steering committee  
Praha, Czech Republic, May 11, 2009
- + Lars Nielsen  
Kursus i måleusikkerhed og metodevalidering  
DFM, June 3, 2009
- + Jan Hald  
Anvendelse af lasere ved Dansk Fundamental Metrologi  
Gæsteforelæsninger i kurset Anvendt laserfysik,  
Aarhus Universitet, October 7, 2009
- + Lars Nielsen  
Kursus i usikkerhedsberegnung med DFM-GUM  
DFM, October 21, 2009
- + Jørgen Garnæs  
Newly developed Danish atomic force microscope show  
surfaces with atomic scale resolution  
Talk for the e-group at The Danish Society of Engineers,  
IDA Ingenørhuset  
Copenhagen October 27, 2009
- + Jørgen Garnæs  
Discover the nano cosmos  
Talk at the meeting Nanotechnology in working clothes  
arranged by FORCE Technology and DFM  
FORCE Technology Brøndby, November 11, 2009
- + Lars Nielsen  
Kursus i avanceret usikkerhedsberegnung  
DFM, December 7-8, 2009.

The association DANIAmet was established on 6 November 2008 by the three member organisations DANIAmet-MI, DANIAmet-CLM and DANIAmet-CDFM. DANIAmet-MI was formerly known as DANIAmet. The association DANIAmet was established to increase the visibility and improve the coordination of Danish metrology, which include fundamental, applied and legal metrology.

The organisation chart for DANIAmet is seen on the next page.

[www.DANIAmet.dk](http://www.DANIAmet.dk)

DANIAmet-MI is member organisation for the Danish metrology institutes, the MIs. They include the National Metrology Institute, DFM, and six Danish Designated Institutes. All of these institutes are nationally designated to maintain and develop either a primary or a reference standard for one ore more measurands.

A focus of DANIAmet-MI is to ensure that all Danish MIs state their Calibration and Measurement Capabilities in appendix C of the Key Comparison Database under the Comité International des Poids et Mesures Mutual Recognition Agreement.

[kcdb.bipm.org/](http://kcdb.bipm.org/)

DANIAmet-MI works to ensure Danish participation in relevant international organisations and through its members to improve and maintain general competences in fundamental metrology of importance to Danish industry.

DANIAmet-MI acts as a common voice for fundamental metrology in Denmark towards the political system and for knowledge transfer among members and to the Danish society.

At present, one of the most important tasks for DANIAmet-MI is the coordination of the Danish participation in the European Metrology Research Programme, EMRP, established as an article 169 institution under the European Treaty as part of the seventh framework programme. The total budget of the EMRP is 400 M€ of which the Danish share is 2 235 k€.

[www.euramet.org/index.php?id=993](http://www.euramet.org/index.php?id=993)

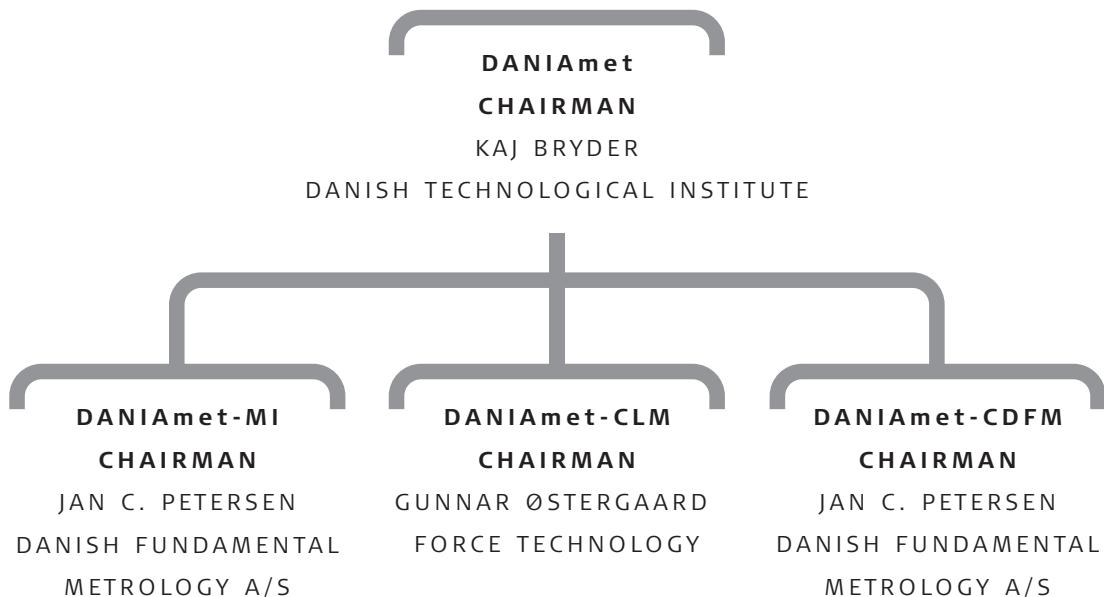
The Danish MIs are currently working mostly in physical measurands. However, efforts are made to inform laboratories within chemistry, health and environment about the advantages of metrology, with the aim to include these laboratories as members of DANIAmet-MI in a few years time.

## FUNDAMENTAL METROLOGY

Fundamental metrology has no international definition, but it generally signifies the highest level of accuracy within a given field. Fundamental metrology may therefore be described as the top level branch of scientific metrology, which deals with the organisation and development of measurement standards and with their maintenance.



## Organisational chart for DANIAmet



DANIAmet-CLM is member organisation for the Danish players within legal metrology.

DANIAmet-CDFM is member organisation for the Danish metrology institutes that are members of GTS – Advanced Technology Group.

[www.teknologiportalen.dk/en](http://www.teknologiportalen.dk/en)

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### COLLABORATION ON PRIMARY LABORATORIES

Metrology is divided into subject fields. More than one Danish MI work within some of these fields.

A number of formalised co-operation agreements has been signed between the involved MIs.

The co-operation laboratories are (with the names of the participating MIs after the name of the laboratory):

#### DANISH PRIMARY LABORATORY FOR ACOUSTICS (DPLA):

Brüel & Kjær Sound & Vibration Measurement A/S and Danish Fundamental Metrology A/S

#### DANISH PRIMARY LABORATORY FOR ELECTRICITY (DPLE):

Danish Fundamental Metrology A/S and Trescal A/S

#### DANISH PRIMARY LABORATORY FOR LENGTH (DPLL):

Technical University of Denmark – DTU Mechanical Engineering, Danish Fundamental Metrology A/S and Danish Technological Institute

**BKSV-DPLA**

Brüel & Kjær Sound &  
Vibration Measurement A/S  
Skodsborgvej 307, DK-2850 Nærum, Denmark  
Contact person for DANIAmet-MI: Torben Licht  
Telephone: +45 7741 2313  
trlicht@bksv.com

**Danish Energy Association**

Rosenørns Allé 9, DK-1970 Frederiksberg C, Denmark  
Contact person for DANIAmet-CLM:  
Hans Jørgen Jensen  
Telephone: +45 3530 0772  
hhj@danskenergi.dk

**DELTA**

DELTA Danish Electronics, Light & Acoustics  
Venlighedsvej 4, DK-2970 Hørsholm, Denmark  
Contact person DANIAmet-MI:  
Anders Bonde Kentved  
Telephone: +45 7219 4275  
abk@delta.dk  
Contact person for DANIAmet-CLM  
and DANIAmet-CDFM:  
Jørgen Duvald Christensen  
Telephone: +45 7219 4217  
jdc@delta.dk

**DFM**

Danish Fundamental Metrology A/S  
Matematiktorvet 307,  
DK-2800 Kgs. Lyngby, Denmark  
Contact person for DANIAmet-MI and  
DANIAmet-CDFM: Jan C. Petersen  
Telephone: +45 4525 5864  
jcp@dfm.dtu.dk

**DTI**

Danish Technological Institute  
Kongsvang Allé 29, DK-8000 Århus C, Denmark  
Contact person for DANIAmet-MI:  
Jan Nielsen  
Telephone: +45 7220 1236  
jan.nielsen@teknologisk.dk  
Contact person for DANIAmet-CLM and  
DANIAmet-CDFM: Kaj Bryder  
Telephone: +45 7220 1220  
kaj.bryder@teknologisk.dk

**DTU**

Technical University of Denmark  
Anker Engelundsvej 1, Bygning 101A,  
DK 2800 Kgs. Lyngby, Denmark  
Contact person for DANIAmet-MI:  
Knut Conradien  
Telephone: +45 4525 1010  
prorektor@adm.dtu.dk

**FORCE**

FORCE Technology  
Navervej 1, 6600 Vejen, Denmark  
Contact person for DANIAmet-MI,  
DANIAmet-CLM and DANIAmet-CDFM:  
Gunnar Østergaard  
Telephone: +45 7696 1603  
gho@force.dk

**Trescal A/S**

Mads Clausens Vej 12, DK-8600 Silkeborg  
Contact person for DANIAmet-MI:  
Torsten Lippert  
Telephone: +45 8720 6969  
torsten.lippert@trescal.com

# REFERENCE LABORATORIES OUTSIDE DANIAMET

A number of laboratories outside DANIAmet work for ministries and governmental agencies. The list below includes laboratories with a formal status as reference laboratory as well as laboratories doing similar work without a formal nomination.

## **DTU AQUA, Technical University of Denmark, National Institute of Aquatic Resources**

Charlottenlund Slot, Jægersborg Allé 1,  
2920 Charlottenlund  
Ministry: Ministry of Science, Technology and Innovation  
Field: Food Chemistry  
Contactperson: Maike Timm Heinrich  
Telephone: +45 3396 3300  
[www.dtu.dk](http://www.dtu.dk)

## **Faculty of Agricultural Sciences, Aarhus University, Department of Integrated Pest Management**

Forsøgsvej 1, Flakkebjerg, 4200 Slagelse  
Ministry: Ministry of Food, Agriculture and Fisheries  
Field: Environmental Chemistry (soil and water)  
Contactperson: Niels Henrik Spliid  
Telephone: +45 8999 1900  
Fax: +45 8999 3501  
[www.agrsci.dk](http://www.agrsci.dk)

## **Danish Institute for External Quality Assurance for Laboratories in the Health Care, DEKS**

Herlev Hospital, Herlev Ringvej 75, 2730 Herlev  
Ministry: Ministry of Health and Prevention  
Field: Laboratory Medicine  
Contactperson: Inger Plum, 54M1  
Telephone: +45 4488 3454  
Fax: +45 4453 5369  
[www.deks.dk](http://www.deks.dk)

## **Eurofins Danmark A/S**

Strandesplanaden 110, 2665 Vallensbæk Strand  
Ministry: Danish Ministry of the Environment  
Field: Environmental Chemistry (water, soil, sludge and waste)  
Contactperson: Ulla Lund  
Telephone: +45 7022 4230  
Fax +45 7022 4255  
[www.eurofins.dk](http://www.eurofins.dk)

## **FORCE Technology – Division for Energy and Environment**

Park Allé 345, 2605 Brøndby  
Ministry: Danish Ministry of the Environment  
Field: Air emission monitoring  
Contactperson: Lars Gram  
Telephone: +45 4326 7000  
Fax: +45 4326 7011  
[www.force.dk](http://www.force.dk)

## **National Environmental Research Institute, Aarhus University, Department of Atmospheric Environment**

Frederiksborgvej 399, 4000 Roskilde  
Ministry: Danish Ministry of the Environment  
Field: Ambient air pollution measurements  
Contactperson: Lone Grundahl  
Telephone: +45 4630 1134  
Fax: +45 4630 1214  
[www.dmu.dk](http://www.dmu.dk)

## **National Environmental Research Institute, Aarhus University, Department of Environmental Chemistry and Environmental Microbiology**

Frederiksborgvej 399, 4000 Roskilde  
Ministry: Danish Ministry of the Environment  
Field: Environmental Chemistry and Microbiology  
Contactperson: Pia Lassen  
Telephone: +45 4630 1200  
Fax: +45 4630 1114  
[www.dmu.dk](http://www.dmu.dk)

## **DTU Food, National Food Institute, Technical University of Denmark**

Mørkhøj Bygade 19, 2860 Søborg  
Ministry: Ministry for Foods, Agriculture and Fisheries  
Field: Food chemistry/food microbiology  
Contactperson: Inge Meyland  
Telephone: +45 3588 7000  
Fax: +45 3588 7001  
[www.dtu.dk](http://www.dtu.dk)

**Danish Medicines Agency,  
Medicines Control Division**

Axel Heides Gade 1, 2300 København S  
Ministry: Ministry of Health and Prevention  
Field: Microbiology, biology, chemistry,  
radioactivity  
Contactperson: Margit Handlos  
Telephone: +45 4488 9720  
Fax: +45 4488 9195  
[www.dkma.dk](http://www.dkma.dk)

**Eurofins Miljø A/S**

Ladelundvej 85, 6600 Vejen  
Ministry: Danish Ministry of the Environment  
Field: Environmental microbiology  
Contactperson: Randi Terp  
Telephone: +45 7022 4266  
Fax: +45 7022 4255  
[www.eurofins.dk](http://www.eurofins.dk)

**Eurofins Steins Laboratorium A/S**

Ladelundsvej 85, 6600 Vejen  
Ministry: Danish Ministry of the Environment  
Field: Microbiology  
Contactperson: Inger Guldbæk  
Telephone: +45 7022 4266  
Fax: +45 7022 4255  
[www.eurofins.dk](http://www.eurofins.dk)

**Danish Plant Directorate**

Skovbrynet 20, 2800 Kongens Lyngby  
Ministry: Ministry for Food, Agriculture  
and Fisheries  
Field: Food chemistry/Environmental chemistry  
Contactperson: Ole P. Kristensen  
Telephone: +45 4596 6603  
Fax: +45 4596 6610  
[www.pdir.fvm.dk](http://www.pdir.fvm.dk)

**Department of Forensic Medicine,  
University of Copenhagen**

Frederik V's vej 11, 2100 København Ø  
Ministry: Ministry of Science,  
Technology and Innovation  
Field: Forensic genetics  
Contactperson: Bo Thisted Simonsen  
Telephone: +45 3532 6136  
Fax: +45 3532 6270  
[www.sund.ku.dk](http://www.sund.ku.dk)

**Department of Forensic Medicine,  
University of Copenhagen**

Frederik V's vej 11, 2100 København Ø  
Ministry: Ministry of Science, Technology  
and Innovation  
Field: Forensic Chemistry  
Contactperson: Kristian Linnet  
Telephone: +45 3532 6100  
Fax: +45 3532 6085  
[www.sund.ku.dk](http://www.sund.ku.dk)

**Statens Serum Institut**

Artillerivej 5, 2300 København S  
Ministry: Ministry of Health and Prevention  
Field: Microbiology  
Contactperson: Helle Bruhn-Rasmussen  
Telephone: +45 3268 8103  
Fax: +45 3268 8124  
[www.ssi.dk](http://www.ssi.dk)

**DELTA**

Venlighedsvej 4, 2970 Hørsholm  
Ministry: Danish Ministry of the Environment  
Field: Noise measurement  
Contactperson: Torben Holm Pedersen  
Telephone: +45 7219 4000  
Fax: +45 7219 4001  
[www.referencelaboratoriet.dk](http://www.referencelaboratoriet.dk)

# THE TWELVE SUBJECT FIELDS OF METROLOGY

In Denmark fundamental metrology is divided into 12 subject fields defined by EURAMET. A Danish contact person has been assigned to each of these fields. The subject fields are divided into a number of subfields that reflects the metrological activities in Denmark. For each subject field, action plans are regularly prepared. These plans motivate the nomination of Metrology Institutes within subject fields of particular importance to Denmark and suggest other metrological initiatives. The years of the action plans are stated in parentheses under the subject field.

Subject field	Contact person	Subfields	Metrology Institute
<b>MASS &amp; RELATED QUANTITIES</b> (1989, 1997, 2008)	Lars Nielsen, DFM ln@dfm.dtu.dk	Mass measurement Force and pressure Volume and density	DFM FORCE FORCE
<b>ELECTRICITY AND MAGNETISM</b> (1989, 1994, 2002)	Hans Dalsgaard Jensen, DFM hdj@dfm.dtu.dk	DC electricity AC electricity HF electricity	DFM Trescal Trescal
<b>LENGTH</b> (1989, 1998, 2007)	Jørgen Garnæs, DFM jg@dfm.dtu.dk	Basic length measurement Dimensional metrology Micro/Nano	DFM DTU & DTI
<b>TIME AND FREQUENCY</b> (1992, 2000)	Jan Hald, DFM jha@dfm.dtu.dk	Time measurement Frequency	
<b>THERMOMETRY</b> (1992, 1999, 2007)	Jan Nielsen, DTI jan.Nielsen@teknologisk.dk	Temperature measurement by contact Non-contact temperature measurement Humidity	DTI DTU DELTA
<b>IONISING RADIATION</b> (1992, 2000)	Arne Miller, DTU armi@risoe.dtu.dk	Absorbed radiation dose – Industrial products Absorbed radiation dose – Medical products Radiation protection Radioactivity	DTU
<b>PHOTOMETRY AND RADIOMETRY</b> (1990, 1996, 2004)	Jan C. Petersen, DFM jcp@dfm.dtu.dk	Optical radiometry Photometry Colorimetry Optical fibres	DFM
<b>FLOW</b> (1990, 1999, 2007)	Gunnar Østergaard, FORCE gho@force.dk	Gaseous flow (volume) Water flow (volume, mass and energy) Flow of liquids other than water Anemometry	FORCE DTI FORCE
<b>ACOUSTICS, ULTRASOUND AND VIBRATION</b> (1992, 2000)	Salvador Barrera-Figueroa, DFM, sbf@dfm.dtu.dk	Acoustical measurements in gases Acoustical measurements in solids Acoustical measurements in liquids	DFM BKSVDPLA
<b>AMOUNT OF SUBSTANCE</b> (1992, 1995, 2004)	Pia Tønnes Jakobsen, DFM ptj@dfm.dtu.dk	Environmental chemistry Laboratory medicine Products and materials Food chemistry Pharmaceutical chemistry Microbiology Electrochemistry	DFM
<b>INTERDISCIPLINARY METROLOGY</b>	Kim Carneiro, DFM kc@dfm.dtu.dk	No subfields	
<b>QUALITY</b>	Jan Hald, DFM jha@dfm.dtu.dk	No subfields	

# DETAILS OF PERSONNEL



## Board of directors

Lars Barkler, CEO, Lithium Balance A/S

Knut Conradsen, Vicepresident, Technical University of Denmark (Vice Chairman)

René Logie Damkjer, Managing Director, Agrotech A/S, Institute for Agri Technology and Food Innovation

Steen Konradsen, Director (Chairman)

Søren Stjernqvist, President, Danish Technological Institute

Kai Dirscherl, MSc (EE), PhD, Staff scientist, DFM A/S

Jan C. Petersen, PhD, Staff Scientist, DFM A/S

## Management

Kim Carneiro, director, MSc (EE), PhD (until May 31)

Michael Kjær, CEO, MSc (EE) (from June 15)

## Accountants

KPMG Statsautoriseret Revisionspartnerselskab

## Staff

Kim Carneiro, MSc (EE), PhD

Lars Nielsen, MSc (EE), PhD

Steen Rahbek, Technician

Hans Dalsgaard Jensen, MSc (EE), PhD

Jan C. Petersen, PhD

Jørgen Garnæs, PhD

Preben Howarth, MSc (EE), BSc (economy)

Peter Høgh Hyllested, Technician

Jan Hald, PhD

Isabella Stendal, Administration

Bo Bengtsen, Technician

Salvador Barrera Figueroa, MSc (EE), PhD

Anne Lumholdt, Administration

Rita Pantoja Lesso, M.Sc. (until July 10)

Pia Tønnes Jakobsen, MSc (EE), PhD

Poul Erik Hansen, PhD

Kai Dirscherl, MSc (EE), PhD

Pia Krog-Pedersen, Administration

Charlotte I. Falk, MSc, PhD student

Zoraya Nieto-Florez, MSc (until July 10)

Guillermo Moreno Pescador (January 15 - December 31)

Niels Kjærgaard, PhD (from June 1)

## Visitors and students

Naia Tabrizian-Ghalehno, DTU Mechanical Engineering (until November 17)

Alessandro Godi, University of Padova (from August 24)

Javis Nwaboh, PTB (September 29 - October 10)

# KEY FIGURES

	2005	2006	2007	2008	2009
<b>Nøgletal i millioner kr.</b>					
Bruttoomsætning	18,3	16,7	16,8	16,8	18,1
Nettoomsætning	15,0	14,9	15,0	15,0	16,8
Årets resultat <sup>1</sup>	0,6	0,3	0,2	0,5	-0,3
Egenkapital <sup>2</sup>	9,4	12,5	12,7	13,2	12,9
Kommerciel omsætning	5,2	2,8	3,9	3,0	2,5
- heraf små virksomheder (under 50 ansatte)	0,4	0,4	0,4	0,3	0,3
- heraf mellemstore virksomheder (50-250)	0,5	0,4	0,5	0,6	0,8
- heraf store virksomheder (over 250 ansatte)	0,2	0,2	0,4	0,5	0,4
- heraf offentlige danske institutioner	0,3	0,2	0,1	0,2	0,3
- heraf udenlandske virksomheder og institutioner	3,8	1,6	2,5	1,5	0,7
Udenlandsk bruttoomsætning	4,5	2,7	3,6	2,2	1,4
<b>Forskning og Udvikling</b>					
Antal samarbejdsprojekter	15	13	8	10	11
- heraf innovationskonsortier	1	1	2	2	2
- heraf internationale projekter	8	6	4	7	4
Forskning og udvikling omsætning (millioner kr.) <sup>3</sup>	13,6	15,4	13,6	14,3	15,4
- heraf egenfinansieret <sup>4</sup>	0,5	1,5	0,9	0,6	0,6
Forskning og udvikling indsats (års værk)	8,7	10,8	8,3	9,4	10,6
<b>Antal kunder</b>					
Danske private virksomheder	27	22	39	51	44
- heraf små virksomheder (under 50 ansatte)	10	10	9	9	10
- heraf mellemstore virksomheder (50-250)	8	7	13	7	10
- heraf store virksomheder (over 250 ansatte)	9	5	17	17	15
Offentlige danske institutioner	3	3	4	8	9
Udenlandske virksomheder og institutioner	19	21	20	29	22
Samlet kundemasse	49	46	63	80	66
<b>Antal medarbejdere efter uddannelse (års værk)</b>					
Dr. & ph.d.	10	10	10	10	9
M.sc.	3	3	3	3	5
Øvrigt teknisk personale	3	3	3	3	3
Administrativt personale	2	2	2	2	3
Gennemsnitligt antal medarbejdere	18	18	18	18	20
<b>Antal publikationer</b>					
Publikationer med bedømmelse	12	8	8	9	5
Afsluttede ph.d.- og eksamsprojekter	4	2	1	1	0
Andre rapporter	60	26	31	41	24
Indlæg ved konferencer	23	20	16	10	5
Kalibreringscertifikater og målerapporter	181	220	228	285	263
Presseklip	36	22	23	9	16
<b>Undervisning</b>					
DFM kurser (antal dage)	33	38	51	25	9
DFM kurser (antal deltagere)	161	201	215	135	26
Vejledere/undervisere på universiteter	3	4	2	3	2
Medvejleding/eksamsprojekter (antal) <sup>5</sup>				3	2
Bidrag til undervisning på universiteter (antal dage) <sup>5</sup>				5	5
Eksternt fagligt arbejde (antal udvalg)	31	25	21	27	30
- heraf internationalt fagligt arbejde	24	20	18	21	20
<b>Effektivitet</b>					
Omsætning pr. medarbejder (1.000 kr.)	1021	924	940	928	925
Overskud pr. medarbejder (1.000 kr.)	32	19	10	29	-18
Kommerciel omsætning pr. resultatkrone	0,6	0,3	0,4	0,3	0,2
FoU-omsætning pr. resultatkrone	0,5	0,7	0,5	1,2	1,2

1) Resultatet er eksklusive ekstraordinære poster

2) Til og med 2005 er tallene for den selvejende institution DFM, herefter for DFM A/S

3) Fra 2004 medtages også nationalt og internationalt samarbejde om metrologi

4) Fra 2005 er egenfinansieringen den efterkalkulerede egenfinansiering

5) Ny opdeling fra 2008

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MANAGEMENT

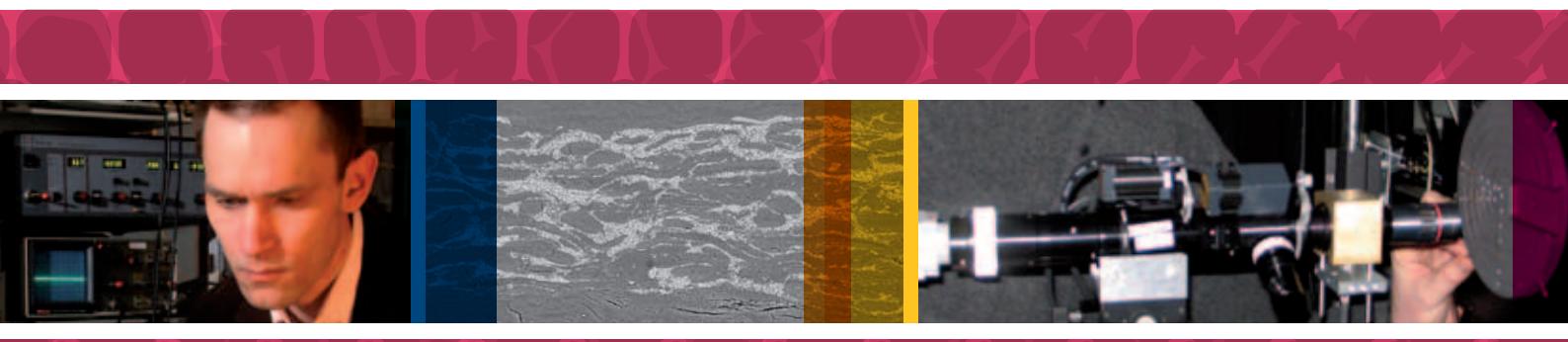
METROLOGY  
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SALES AND  
MARKETING



## MISSION

*To develop and disseminate measurement knowledge at an international scientific level with focus on Danish interests.*